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#### Article

# Unveiling Nanoscale Compositional and Structural Heterogeneities of Highly Textured $Mg_{0.7}Ti_{0.3}H_y$ Thin Films

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**ABSTRACT:** Thin films often exhibit fascinating properties, but the understanding of the underlying mechanism behind such properties is not simple. This is partially because of the limited structural information available. The hurdle in obtaining such information is especially high for textured thin films such as Mg-rich  $Mg_xTi_{1-xy}$  a promising switchable smart coating material. Although these metastable thin films are seen as solid solution alloys by conventional crystallographic methods, their hydrogen-induced optical transition is hardly understood by a solid solution model. In this study, we collect atomic pair distribution function (PDF) data for a  $Mg_{0.7}Ti_{0.3}H_y$  thin film in situ on hydrogenation and successfully resolve TiH<sub>2</sub> clusters of an average size of 30 Å embedded in the Mg matrix. This supports the chemically



segregated model previously proposed for this system. We also observe the emergence of a previously unknown intermediate face-centered tetragonal phase during hydrogenation of the Mg matrix. This phase appears between Mg and MgH<sub>2</sub> to reduce lattice mismatch, thereby preventing pulverization and facilitating rapid hydrogen uptake. This work may shed new light on the hydrogen-induced properties of Mg-rich  $Mg_xTi_{1-x}$  thin films.

# ■ INTRODUCTION

Thin-film deposition is one of the controlled synthesis methods that allow the preparation of materials in unique architectures. For instance, we can bind thin layers of various materials together to make heterogeneous substances or grow metastable materials that do not appear in equilibrium phase diagrams.<sup>1–4</sup> Such thin films often exhibit fascinating properties and hence play an important role in a wide range of applications these days including transparent electronics, memories, optical coatings, and renewable energy,<sup>5–8</sup> and thin film deposition will take on great significance for next-generation functional materials.<sup>9,10</sup> However, the structural determination of thin films, especially on the nanoscale, is not straightforward and this leads to a limited understanding of the properties of thin films.

Mg-rich  $Mg_x Ti_{1-x}$  thin films prepared by magnetron sputter deposition exhibit interesting hydrogen-induced optical transition properties: a highly reflective metallic film transforms to a strong absorber of solar radiation with a low thermal emissivity by hydrogen absorption.<sup>11</sup> These thin films have a wide range of potential applications such as switchable smart coatings for solar collectors<sup>12,13</sup> and hydrogen sensors.<sup>14</sup> Which structural features give rise to such compelling properties is of great interest. X-ray diffraction (XRD) and selected area electron diffraction studies suggest that  $Mg_x Ti_{1-x}$  thin films are "solid solution alloys" having a hexagonal-closepacked (hcp) structure and they transform on hydrogenation into face-centered-cubic (fcc)-based hydrides.<sup>15</sup> However, the formation of Mg–Ti solid solutions is questionable because Mg and Ti are immiscible.<sup>16</sup> Moreover, a simple solid solution model does not account for the optical and electrical properties of the hydrogenated thin films. In particular, high optical absorption suggests a mixture of metallic TiH<sub>2</sub> particles in a dielectric MgH<sub>2</sub> matrix having a coherently integrated structure, as shown in Figure 1.<sup>15,17</sup>

Some indirect evidence for the presence of  $\text{TiH}_2$  clusters in Mg-rich  $Mg_x\text{Ti}_{1-x}\text{H}_y$  thin films has been presented by extended X-ray absorption fine structure (EXAFS)<sup>18</sup> and positron annihilation<sup>19</sup> studies. Furthermore, theoretical calculations have shown that clustering of Ti atoms in Mg-rich thin films can effectively lower the mixing enthalpy per Ti atom.<sup>20</sup> Although these results support a chemically segregated but structurally coherent model for  $Mg_x\text{Ti}_{1-x}\text{H}_y$  thin films, direct

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**Figure 1.** Schematic drawing of hydrogen uptake process of Mg-rich  $Mg_xTi_{1-x}$  thin films suggested in ref 15. In as-deposited thin films, Ti clusters are coherently embedded in a Mg matrix. On hydrogenation Ti clusters absorb hydrogen first and the Mg matrix absorbs hydrogen later.

experimental evidence for this unique structure and its details, such as the size and lattice expansion of the  $TiH_2$ -clusters, are still missing. This is mainly because the strong texture makes structure determination difficult.

The fact that conventional XRD perceives  $Mg_rTi_{1-r}H_v$  thin films as solid solutions implies that chemical segregation occurs on a nanometer scale: the suggested TiH<sub>2</sub> clusters cannot be larger than a few nanometers. Identifying such small clusters coherently embedded in a matrix having a structure similar to that of the clusters is not straightforward and requires techniques that allow exploration of the atomic arrangement across multiple length scales. The PDF technique<sup>21</sup> is a powerful local structural probing technique that has been successfully applied to resolving nanoscale structural features in various materials.<sup>22-24</sup> The successful investigation of amorphous and crystalline FeSb3 thin films using PDF was carried out by Jensen previously.<sup>25</sup> More recently, grazingincidence X-ray diffraction has been successfully applied for the PDF study of Pt thin films.<sup>26</sup> However, we cannot utilize the same experimental setup for highly textured thin films.

In this work, we introduce a simple way of solving a preferred orientation problem to obtain X-ray PDFs of highly textured thin films. Our in situ PDFs of Mg<sub>0.7</sub>Ti<sub>0.3</sub> thin films obtained during hydrogen absorption clearly show the presence of TiH<sub>2</sub> clusters with an average size of 30 Å embedded in a Mg matrix. During hydrogen uptake, the Mg matrix exhibits an intermediate face-centered-tetragonal (fct) phase that has not been reported before and the fully hydrogenated Mg matrix adopts an fcc structure imposed by the TiH<sub>2</sub> clusters. We also demonstrate how our PDF results and previous optical measurement results complement each other to reveal the extent of intermixing of immiscible Mg and Ti in TiH<sub>2</sub> clusters. This work demonstrates the great potential of the PDF technique for investigating nanoscale structural features in highly textured multicomponent thin films, which may be closely linked to their properties.

#### EXPERIMENTAL METHODS

PDF analysis is often performed on isotropic scattering data.<sup>21</sup> However, highly textured thin films usually yield only a few intense Bragg peaks, as shown in Figure S1c, and lead to PDFs with incomplete structural information (Figure S3a). This preferred orientation problem has been a major barrier to the PDF analysis of highly textured thin films. Although three-dimensional PDF analysis<sup>27–29</sup> is an ideal method for our study, it is experimentally more challenging and mathematically more complicated than PDF analysis of powder samples. In this study, we tried to obtain powder-

diffraction-like data from thin films by adopting the following approach. We deposited a  $Mg_{0.7}Ti_{0.3}$  thin film on a thin Kapton sheet, then cut it into small pieces, and packed the pieces in a Kapton capillary. A schematic overview of the experimental procedures is shown in Figure S2a. X-ray total scattering data obtained in this way display many Bragg peaks (Figure S2c), and the corresponding PDF clearly determines the hcp structural correlation of the thin film (Figure S3b). The shape of diffraction peaks measured in this way is virtually identical with that from an uncut film (Figure S4). This demonstrates that cutting the thin film has not altered the crystal morphology, microstructure, and crystalline defects of the sample significantly. We tried to obtain delaminated thin films for comparison but failed. Even scraping off the thin film from substrates was difficult. Therefore, we think that severe delamination of the thin films did not occur.

Two  $Mg_{0.7}Ti_{0.3}$  thin films of 400 nm thickness were prepared. These thin films have different thicknesses of a Pd capping layer, i.e. 1.5 nm (designated by  $Mg_{0.7}Ti_{0.3}$ -1) and 2.5 nm (designated by  $Mg_{0.7}Ti_{0.3}$ -2) and provide different rates of hydrogen uptake. Since Ti clusters and the Mg matrix absorb hydrogen at different rates,  $Mg_{0.7}Ti_{0.3}$ -1 is better matched to the faster hydrogenation process of the Ti clusters and  $Mg_{0.7}Ti_{0.3}$ -2 is better matched to the slower hydrogenation process of the Mg matrix. By using these two thin films, structural changes in the Ti clusters and the Mg matrix during hydrogen absorption can be unambiguously resolved (see Sample Preparation in the Supporting Information for details).

Synchrotron X-ray total scattering experiments were conducted at the BL22XU beamline at SPring-8.30 The thin films were cut into small pieces with various shapes (square or ribbonlike shapes in the size  $\leq 5 \times 0.6 \text{ mm}^2$ ) and loaded them in in situ gas loading cells.<sup>3</sup> Details of our in situ cells and in situ gas loading setup can be found in ref 31. All the data of the thin films were collected at 300 K using the rapid acquisition pair distribution function (RA-PDF) technique.<sup>3</sup> For the experiment on the  $Mg_{0.7}Ti_{0.3}$ -1 thin film (the  $Mg_{0.7}Ti_{0.3}$ -2 thin film), a large image plate detector, R-AXISV manufactured by Rigaku (an amorphous silicon detector manufactured by PerkinElmer) was mounted orthogonal to the incident X-ray beam of 70.430 keV (69.933 keV). The sample to detector distance was determined geometrically using diffraction profiles of a standard sample, CeO<sub>2</sub>, measured at several different distances, and it was 300 mm. The in situ cell was spun for  $\pm 30^\circ$  during data collection. For the  $Mg_{0.7}Ti_{0.3}\text{-}1$ thin film, data were collected while 1 MPa of hydrogen gas was being applied. Each point of the data was collected for 60 s. For the Mg07Ti03-2 thin film, as soon as 0.2 MPa of hydrogen gas was applied, hydrogen absorption started and data were collected during the reaction. For each data set, 240 frames of 2 s image data were collected continuously.

Image data were first integrated to one-dimensional data using the WinPIP program, which is derived from the PIP program<sup>33</sup> and developed at BL22XU at Spring-8, and series of integrated data were summed. Using the program PDFgetX2<sup>34</sup> the signal from an empty cell was subtracted from the raw data, Compton scattering and Laue diffuse scattering corrections were made, and the X-ray PDFs were obtained.  $Q_{max} = 16$  Å<sup>-1</sup> was used. Real space modeling was carried out using the program PDFgui.<sup>35</sup> Basic information about PDF modeling is available in the Supporting Information.

# RESULTS AND DISCUSSION

The low-2 $\theta$  region of the X-ray total scattering data of the Mg<sub>0.7</sub>Ti<sub>0.3</sub>-2 thin film is shown in Figure 2. Before hydrogen uptake, three slightly broad but well distinct diffraction peaks corresponding to the (010), (002), and (011) reflections of an hcp structure are observed. The lattice parameters corresponding to these diffraction peaks are a = b = 3.1041(9) Å and c = 4.989(2) Å, which are smaller than the lattice parameters of Mg (a = b = 3.2085 Å and c = 5.2106 Å) but larger than those of Ti (a = b = 2.95111 Å and c = 4.68433 Å).<sup>36,37</sup> As soon as hydrogen absorption begins, these three diffraction peaks



Figure 2. X-ray total scattering data of a  $Mg_{0.7}Ti_{0.3}$ -2 thin film collected during the hydrogenation process. Small vertical lines below the data indicate the positions of the (010), (002), and (011) reflections of an hcp structure and the positions of the (111) and (002) reflections of an fcc structure.

slightly shift to lower  $2\theta$  angles as if a hydrogen solid solution phase is formed, in which a small amount of hydrogen randomly occupies interstitial sites of the metal lattice. As hydrogen uptake proceeds further, the intensities of these diffraction peaks gradually decrease and concurrently new peaks emerge at  $2\theta \approx 3.8$  and  $4.37^{\circ}$ . These new peaks can be assigned to the (111) and (002) reflections of an fcc structure, respectively, and continuously grow until the hcp reflections have completely disappeared. The lattice parameter of the fcc phase corresponding to the diffraction peaks of the fully hydrogenated sample is a = 4.616(1) Å, which is larger than the reported value for bulk TiH<sub>2</sub> (a = 4.4512 Å).<sup>38</sup>

Both bulk magnesium and titanium crystallize in the hcp structure (space group  $P6_3/mmc$ ). On hydrogenation they transform into MgH<sub>2</sub> with a rutile-type tetragonal structure (space group  $P4_2/mnm$ ) and TiH<sub>2</sub> with a fluorite-type fcc structure (space group  $Fm\overline{3}m$ ), respectively.<sup>39</sup> This is a firstorder phase transformation, and hence, a hydrogen solid solution phase (e.g., MgH<sub> $\delta$ </sub> or TiH<sub> $\delta$ </sub>) and a hydride phase (e.g.,  $MgH_2$  or  $TiH_2$ ) coexist in the system during transition. The diffraction patterns shown in Figure 2 suggest that the hydrogenation process of the Mg<sub>0.7</sub>Ti<sub>0.3</sub> thin film is comparable to that of bulk Ti: a hydrogen solid solution phase having an hcp structure transforms into a hydride phase having an fcc structure via a mixed-phase regime. This is in accord with previous X-ray and TEM study results. Changes in diffraction peaks remind us of nothing but a solid solution alloy thin film and do not give any clues to chemical segregation.

Figure 3 shows the PDFs obtained during hydrogenation of the Mg<sub>0.7</sub>Ti<sub>0.3</sub>-1 thin film. Before hydrogenation, a single hcp model (a Mg<sub>0.7</sub>Ti<sub>0.3</sub> solid solution model) is sufficient to explain the experimental PDF over a wide *r* range, 1.5 < r < 80Å (Figure 3a). The refined lattice parameters are a = b =3.115(1) Å and c = 5.005(3) Å. These are smaller than the lattice parameters of Mg (a = b = 3.2085 Å and c = 5.2106 Å) but larger than those of Ti (a = b = 2.95111 Å and c = 4.68433Å). $^{36,37}$  Interestingly, these values are rather close to the calculated values for a  $Mg_{0.7}Ti_{0.3}$  solid solution alloy (a = b =3.1313 Å and c = 5.0527 Å) using Vegard's law.<sup>40</sup> This good fit is obtained at the expense of a large isotropic atomic displacement parameter  $(U_{iso} = 0.041(7) \text{ Å}^2)$ , indicating the presence of large random displacement in the sample.<sup>41</sup> We also tried two-phase modeling using a nanosized hcp Ti model and an hcp Mg model. However, the fit did not improve despite a greater number of parameters being used. Moreover, the refined  $U_{\rm iso}$  value for Ti was very large  $(U_{\rm iso} \sim 0.4 \text{ Å}^2)$ . As



**Figure 3.** PDFs of the  $Mg_{0.7}Ti_{0.3}$ -1 thin film obtained during hydrogen absorption. The experimental PDFs of (a) the as-deposited thin film and (b, c) the thin film during hydrogenation are compared with the calculated PDFs of refined hcp  $Mg_{0.7}Ti_{0.3}$  structure models. The difference between the measured and the calculated PDFs is presented by the lower green line. (d) Two-phase fit to the experimental PDF shown in (c) using an fcc TiH<sub>2</sub> nanoparticle model and an hcp Mg model. The PDF in (c) and (d) is the state in which hydrogenation of Ti clusters is completed. The amount of absorbed hydrogen (H/M = the number ratio of hydrogen to metal atoms) is estimated from the refined phase fraction of TiH<sub>2</sub>.  $R_{wp}$  is the goodness of fit. The  $R_{wp}$  value of (a) is comparable to those obtained from FeSb<sub>3</sub> thin films in ref 25.

we mentioned earlier, the as-deposited thin film is largely disordered and this makes detailed PDF features indistinct. Consequently, it is difficult to distinguish two hcp structures having similar lattice parameters from the low-*r* region of the PDF. Therefore, no clear hint of chemical segregation is found in this PDF.

When 1 MPa of hydrogen gas is applied, the film first slightly expands its volume but keeps the hcp structure. The lattice parameters increase to a = b = 3.130(2) Å and c = 5.051(1) Å (Figure S5). This indicates the formation of a hydrogen solid solution phase. The fit in this case is as good as in the asdeposited case, and the refined  $U_{iso}$  value decreases slightly to 0.038(3) Å<sup>2</sup>. As hydrogenation proceeds further, new features arise in the PDF (Figure 3b). These features only appear at  $r \leq 30$  Å and continuously grow (Figure 3c). In contrast, the high-r region ( $r \geq 30$  Å) remains unchanged. Modeling these data reveals that new intensities are due to the formation of a fluorite-type fcc phase. As shown in Figure 3d, a significantly improved fit is obtained by combining an hcp Mg model and a fluorite-type fcc TiH<sub>2</sub> nanoparticle model. The atomic ratio of

Mg to Ti obtained from PDF refinement is 0.67:0.33, close to the target composition. This PDF result unambiguously reveals that the Mg<sub>0.7</sub>Ti<sub>0.3</sub> thin film at this stage consists of Ti-rich regions with an average size of 30 Å (TiH<sub>2</sub> clusters) and Mgrich regions with a structural coherence length larger than 80 Å (a Mg matrix). The result is more or less consistent with the chemical segregation picture proposed in ref 15 (Figure 1). Although two-phase modeling provides a fairly good fit, broad fluctuations in the low-*r* region of the difference curve (Figure 3d) indicate that some PDF features are still not explained. These features are most likely from the interface between fcc TiH<sub>2</sub> clusters and the hcp Mg matrix. The refined lattice parameter for the TiH<sub>2</sub> nanoparticle model is a = 4.516(9) Å. The value is larger than the reported value for bulk  $TiH_2$  (*a* = 4.4512 Å)<sup>38</sup> probably due to the presence of some larger Mg atoms inside TiH<sub>2</sub> clusters or the coherent clamping of TiH<sub>2</sub> clusters with the Mg matrix. We will discuss about this point in detail later. A spherical nanoparticle model was used to explain the TiH<sub>2</sub> clusters, and the particle size fluctuates with the PDF profile parameters around 30 Å (between 25 and 36 Å). This is probably because the clusters do not have a spherical shape.

To investigate structural change in the Mg matrix on hydrogenation, we analyzed the PDF data obtained from the  $Mg_{0.7}Ti_{0.3}$ -2 thin film. We focus on change in the 30 < r < 80 Å region, where the contribution of the Mg matrix is predominant. As shown in Figure 4a, the as-deposited Mg<sub>0.7</sub>Ti<sub>0.3</sub> thin film exhibits sharp PDF peaks representing an hcp structure. This indicates the presence of well-defined structural correlation over a long distance. Lattice parameters obtained by fitting the 30 < r < 80 Å region are a = b =3.130(1) Å and c = 5.031(5) Å. These are slightly larger than the values obtained from the  $Mg_{0.7}Ti_{0.3}$ -1 thin film. At a point 600 s after the introduction of 0.2 MPa of hydrogen gas, a hydrogen solid solution phase with lattice parameters of a = b= 3.142(6) Å and c = 5.070(3) Å is formed. Hydrogenation progresses steadily. The experimental PDF shown in Figure 4b represents the state where most of the Ti clusters are transformed to the fcc hydride phase. The low-r region of this PDF is well explained by a nanosized fcc TiH<sub>2</sub> model and an hcp Mg model as shown in Figure S6. Although a small variation in peak intensity is seen in Figure 4b, the hcp structural features in this region remain intact. The lattice parameters become slightly larger than those of the hydrogen solid solution phase ( $\delta a = \delta b = 0.008$  Å,  $\delta c = 0.018$  Å; see Table S1) probably due to the hydrogenation of the Ti clusters and the resulting lattice expansion thereof. Unaltered PDF features at r > 30 Å and a subtle change in the lattice parameters of the hcp matrix at this stage suggest the possibility of pre-existing Ti clusters in the as-deposited thin films. If TiH<sub>2</sub> clusters were formed from a Mg-Ti random alloy by hydrogenation, we would have seen a much larger change in the lattice parameters of the hcp matrix due to the occurrence of chemical segregation (alloying of Mg with 30 atom % of Ti will lead to changes in lattice parameters by  $\delta a \approx$ -0.077 Å and  $\delta c \approx -0.158$  Å). The fit shown in Figure S6 yields an atomic ratio of Mg to Ti of 0.71:0.29. This thin film is slightly richer in Mg than the other film.

After the hydrogenation of Ti clusters is completed (3000 s after hydrogen introduction), fluorite-type fcc structural features start to emerge at r > 30 Å (Figure 4c). Since there is a long interval of time between the advent of fcc signals in this region and in the region of r < 30 Å (1260 s), we attribute this change to the metal hydride transformation of the Mg



**Figure 4.** 30 < r < 80 Å region of the PDFs of Mg<sub>0.7</sub>Ti<sub>0.3</sub>-2 thin film. Experimental PDFs of (a) the as-deposited thin film and (b) the complete hydrogenation state of Ti clusters are shown and an hcp Mg model is fit to the data. (c) One of the PDFs obtained during the hydrogenation of the Mg matrix is shown. An fcc MgH<sub>2</sub> model is used to fit the PDF. (d) PDF of the complete hydrogenation state of the Mg matrix. A single fcc MgH<sub>2</sub> model explains all the PDF features.

matrix. During this transition, the 30 < r < 80 Å region should be explained by a combination of two structure models: i.e. an hcp structure model for the metal part and a fluorite-type fcc structure model for the hydride part. However, such two-phase modeling provides an imperfect fit (Figure 5a); in particular, features at r > 57 Å are poorly reproduced. It turns out that to fully understand structural changes in this region an fct model, which is close to the fluorite-type fcc structure but whose one cell axis is slightly shorter than the others, is necessary. Figure 5b shows the result of three-phase modeling. Now, all the PDF features at r > 57 Å are well reproduced and even the r < 57 Å region is explained better. None of the combinations of any two models yield such a good fit. The refined structural parameters are given in Table S2. Note that we did not see the formation of the fcc and fct  $MgH_2$  phases in  $Mg_{0.7}Ti_{0.3}\mbox{--}1$  thin film because its hydrogen uptake rate is too slow to detect the slower hydrogenation process of the Mg matrix during the experiment.

Hydrogen absorption by the thin film slows down as the metal to hydride transformation of the Mg matrix progresses. After nearly 90% of the Mg matrix underwent transformation, only a very subtle change occurred in the PDF over time. One of the possible reasons for a decrease in hydrogenation rate of the Mg matrix is discussed in the Supporting Information. To



Figure 5. Experimental PDF of  $Mg_{0.7}Ti_{0.3}$ -2 thin film shown in Figure 4c. (a) An hcp Mg model and an fcc  $MgH_2$  model (two-phase modeling) and (b) an hcp Mg model, an fcc  $MgH_2$  model, and an fct  $MgH_2$  model (three-phase modeling) were fit to the experimental PDF.

accelerate the reaction, the sample was heated at 373 K for 120 s under a hydrogen gas environment. After heating, it reached the state of complete hydrogenation. A single fluorite-type fcc structural model yields an excellent fit (Figure 4d), indicating that the Mg matrix completely transforms to the fcc hydride phase. An excellent two-phase fitting result using an fcc TiH<sub>2</sub> nanoparticle model and an fcc MgH<sub>2</sub> model over a wider *r* range, 1.5 < r < 80 Å, is shown in Figure S7.

The Mg matrix exhibits two interesting characteristics. First, while bulk Mg forms a rutile-type tetragonal hydride, the Mg matrix of the Mg<sub>0.7</sub>Ti<sub>0.3</sub> thin film forms a fluorite-type fcc hydride. There are two reported Mg-based hydrides having a fluorite-type fcc metal sublattice. One of these is a highpressure polymorph of  $MgH_2$  having a modified fluorite structure (space group  $Pa\overline{3}$ ).<sup>42,43</sup> Interestingly, its lattice constant (a = 4.6655 Å) is close to that of our fully hydrogenated Mg matrix (a = 4.658 Å). The other known hydride is Mg7TiH12.7. In this phase, Mg is arrayed in a doubled TiH<sub>2</sub> unit cell and Ti atoms occupy the 4a site (Ga<sub>7</sub>Ge-type structure, a = 9.532 Å).<sup>44</sup> At present, it is not clear whether the fully hydrogenated Mg matrix forms either of these hydride phases, but it is apparent that it does not take a rutile-type tetragonal structure. Then, what causes the formation of an fcc MgH<sub>2</sub> matrix? We may think of reduced dimensionality or clamping effect from the substrate as a possible cause. However, our unpublished PDF study shows that a Ti-free MgH<sub>2</sub> thin film of 400 nm thickness takes a rutile-type tetragonal structure. Indeed, fcc MgH<sub>2</sub> is observed in Mg<sub>x</sub>Ti<sub>1-x</sub>H<sub>y</sub> thin films for only  $x < 0.85^{15,45}$  and is not found in Mg-Ti-H multilayer thin films.<sup>46,47</sup> All of these indicate that nanosized Ti clusters (or TiH2 clusters) play an important role and they strongly interact with the Mg matrix. In other words, they are structurally integrated as suggested in ref 15 (Figure 1). A change in the PDF peak widths of the Mg matrix during hydrogenation also hints at the structural integration (see the Supporting Information).

The other interesting characteristic of the Mg matrix is the emergence of an fct MgH<sub>2</sub> phase during transition. This phase

was not reported previously. None of the known high-pressure polymorphs of  $MgH_2$  take an fct structure. Figure 6a shows



**Figure 6.** (a) Phase fraction of hcp Mg, fct  $MgH_2$ , and fcc  $MgH_2$  during hydrogenation of the Mg matrix are plotted as a function of reaction time. (b) A schematic diagram of the development of fct  $MgH_2$  and fcc  $MgH_2$  is shown.

how the phase fraction of hcp Mg, fct  $MgH_2$ , and fcc  $MgH_2$ varies during hydrogen uptake by the Mg matrix. The fct phase appears concurrently with the fcc  $MgH_2$  phase. The development of these two phases is very rapid at the beginning but gradually slows down after more than 66% of the Mg matrix transforms into either of these phases. Their phase fractions are comparable to each other throughout the transition, but at the end of the transition the fct phase disappears with the hcp phase. It appears that fct  $MgH_2$  can be present only when fcc  $MgH_2$  and hcp Mg coexist.

The hcp–fcc phase transformation is observed in numerous materials,<sup>48–53</sup> and there are a few cases where an intermediate phase (or an intermediate structure) having characteristics similar to those of our fct MgH<sub>2</sub> phase is seen.<sup>52,53</sup> This intermediate structure is formed at the interface between the hcp and the fcc structures to decrease the distortion energy caused by a lattice mismatch and disappears when the transition is completed. A similar intermediate phase is also found in LiFePO<sub>4</sub> during nonequilibrium battery operation to reduce a lattice mismatch between LiFePO<sub>4</sub> and FePO<sub>4</sub> and to promote a fast phase transition.<sup>54</sup>

The X-ray diffraction pattern of an as-deposited  $Mg_{0.7}Ti_{0.3}$  thin film measured in reflection geometry shows only the (002) reflection of an hcp structure.<sup>15</sup> After hydrogenation, the (111) reflection of an fcc structure is seen. It can be easily deduced that the hcp to fcc structural change occurs via the conversion of (002) planes of the hcp structure into (111) planes of the fcc structure. The interplanar distance of (002) planes of hcp Mg and that of (111) planes of fcc MgH<sub>2</sub> obtained from the refined lattice parameters in Table S2 are 2.549 and 2.697 Å, respectively. The interplanar spacing of

(111) planes of fct MgH<sub>2</sub> is 2.659 Å. Thus, it is most likely that fct MgH<sub>2</sub> is formed between hcp Mg and fcc MgH<sub>2</sub> to reduce distortion energy caused by a lattice mismatch between them (Figure 6b). Note that the interplanar spacing of (111) planes of fcc TiH<sub>2</sub> is 2.642 Å, comparable to that of fct MgH<sub>2</sub>. The presence of the fct MgH<sub>2</sub> phase probably prevents Mg<sub>0.7</sub>Ti<sub>0.3</sub> thin films from pulverization that often occurs during hydrogenation of bulk materials owing to large volume expansion. Therefore, it allows these metastable thin films to retain their structure over several hydrogenation and dehydrogenation cycles and promotes fast hydrogen uptake.<sup>45</sup>

Finally, we utilize the optical transmission measurement results in ref 17 to explain the lattice parameter of the TiH<sub>2</sub> clusters. Gremaud et al. measured pressure-optical-transmission isotherms of  $Mg_xTi_{1-x}H_y$  thin films by using hydrogenography<sup>55</sup> and extracted the values for the chemical short-range order parameter (s) and the parameter related to the degree of local deformation of a cluster embedded in an alloy (L). Details of these parameters can be found in ref 17. From their optical analysis Gremaud et al. obtained s = 0.34and L = 0.2 for a Mg<sub>0.7</sub>Ti<sub>0.3</sub> thin film. They could not determine a cluster size. Our PDF analysis showed that the average size of the TiH<sub>2</sub> clusters in the hydrogenated  $Mg_{0.7}Ti_{0.3}$ -2 thin film is ~30 Å. For a 30 Å TiH<sub>2</sub> cluster embedded in a Mg matrix to have s = 0.34, approximately 17% of the constituent atoms should be Mg (see the Supporting Information for details). By simply adopting Vegard's law with the lattice parameters of bulk TiH<sub>2</sub> (a = 4.4512 Å) and the high-pressure phase of MgH<sub>2</sub> having a modified fluorite structure (a = 4.6655 Å), we obtain a = 4.4876 Å for Mg<sub>0.17</sub>Ti<sub>0.83</sub>H<sub>2</sub>. This value is still smaller than the lattice parameter of the TiH<sub>2</sub> clusters obtained from PDF analysis, a =4.572 Å. If we consider the local deformation of the cluster due to coherent embedment in an alloy matrix as mentioned in ref 17, the lattice parameter of our model becomes 4.5784 Å. This is very close to the value obtained from PDF analysis. This shows that the PDF results are essentially consistent with optical measurement results and additional information such as the average chemical composition of TiH<sub>2</sub> clusters, which is Mg<sub>0.17</sub>Ti<sub>0.83</sub>H<sub>v</sub>, can be extracted. More importantly, this result sheds light on how compositional modulation occurs in metastable thin films created between immiscible elements.

# CONCLUSIONS

In conclusion, the structural evolution of highly textured Mg<sub>0.7</sub>Ti<sub>0.3</sub> thin films during hydrogenation was investigated by using PDF analysis. Our study clarifies the presence of TiH<sub>2</sub> clusters of an average size of  $\sim$ 30 Å and confirms previous findings that the hydrogenated Mg matrix takes an fcc structure. During hydrogenation of the Mg matrix a previously unknown MgH<sub>2</sub> intermediate phase having an fct structure was observed. This intermediate phase is probably important for the structural stability of this metastable thin film during hydrogen uptake. We also showed how PDF and optical measurement results complement each other to provide information on the average composition of TiH<sub>2</sub> clusters and a better picture of how compositional modulation occurs in this system. Our method can be applied to a wide variety of thin films to resolve nanoscale compositional and structural heterogeneities, which are closely linked to their fascinating properties, and the structural response of each constituent part during various physical and chemical reactions.

#### ASSOCIATED CONTENT

#### **Supporting Information**

The Supporting Information is available free of charge at https://pubs.acs.org/doi/10.1021/acs.inorgchem.0c00059.

Comparison of data obtained using two different setups, sample preparation, PDF fitting results, refined structural parameters, and calculations for the lattice parameter of TiH<sub>2</sub> clusters (PDF)

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# Notes

The authors declare no competing financial interest.

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